

March 2013

FQP85N06

N-Channel QFET® MOSFET 60 V, 85 A, 10 m Ω

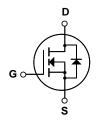
Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 85 A, 60 V, $R_{DS(on)}$ =10 m $\Omega(Max.)$ @ V_{GS} =10 V, I_D =-42.5 A
- Low Gate Charge (Typ. 86 nC)
- Low Crss (Typ. 165 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

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Symbol	Parameter		FQP85N06	Unit
V_{DSS}	Drain-Source Voltage		60	V
I_D	Drain Current - Continuous ($T_C = 25^{\circ}C$)	(Note 6)	85	Α
	- Continuous (T _C = 100°C)	60	А
I _{DM}	Drain Current - Pulsed	(Note 1)	300	А
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	810	mJ
I _{AR}	Avalanche Current	(Note 1)	85	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	16.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	7.0	V/ns
P _D	Power Dissipation (T _C = 25°C)		160	W
	- Derate above 25°C		1.07	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C
'L			300	

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.94	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	racteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.06		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 48 V, T _C = 150°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10 V, I _D =42.5 A		0.008	0.010	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 25 V, I _D = 42.5 A (Note 4)		54		S
	ic Characteristics		T	T	T	
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		3170	4120	pF -
Coss	Output Capacitance	f = 1.0 MHz		1150	1500	pF -
C _{rss}	Reverse Transfer Capacitance			165	220	pF
Switchi	ng Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 30 V, I _D = 42.5 A,		40	90	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		230	470	ns
t _{d(off)}	Turn-Off Delay Time	- 1.6 - 2 - 2		175	360	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		170	350	ns
Qg	Total Gate Charge	V _{DS} = 48 V, I _D = 85 A,		86	112	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		20.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		36		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				85	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	Diode Forward Current			300	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 85 A			1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 85 A,		70		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		135		nC

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature 2. L = 130μH, I_{AS} = 85A, V_{DD} = 25V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} \leq 85A, di/dt \leq 300A/μs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test: Pulse width \leq 300μs, Duty cycle \leq 2% 5. Essentially independent of operating temperature 6. Continuous Drain Current Calculated by Maximum Junction Temperature: Limited by Package

Typical Characteristics

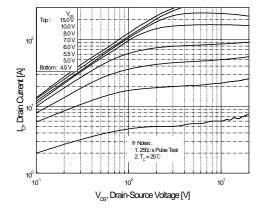


Figure 1. On-Region Characteristics

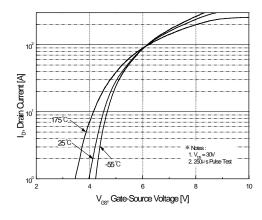


Figure 2. Transfer Characteristics

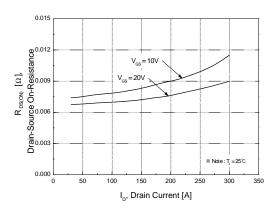


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

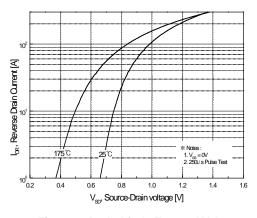


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

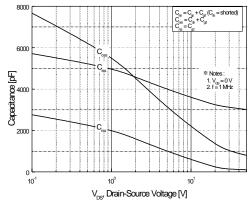


Figure 5. Capacitance Characteristics

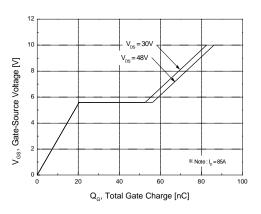
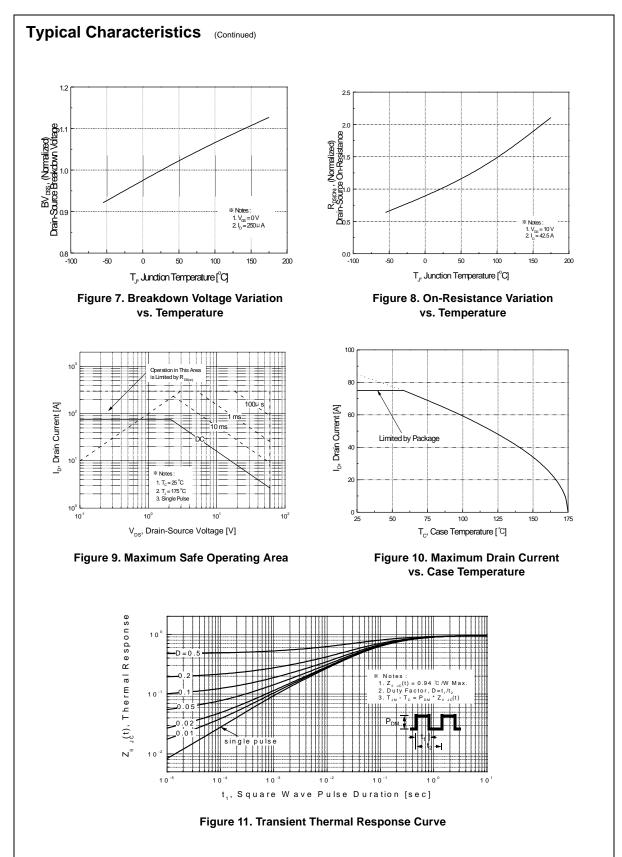
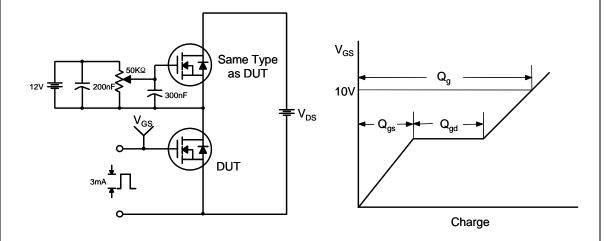


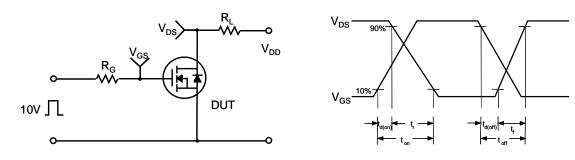
Figure 6. Gate Charge Characteristics



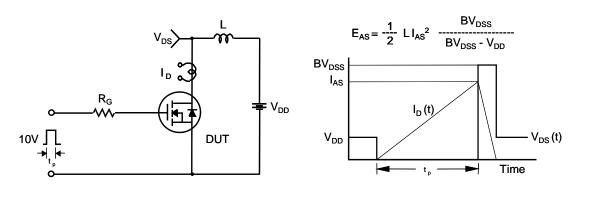
Gate Charge Test Circuit & Waveform

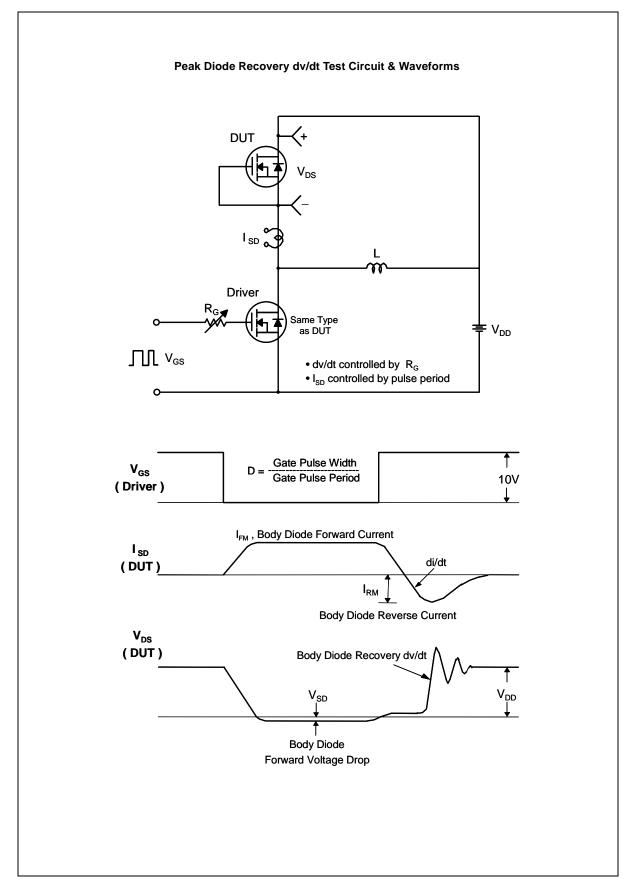


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms





Mechanical Dimensions TO-220 ⊕ 0,36 M B AM 4.83 3.56 Α 10.67 9.65 8.89 6.86 3.43 2.54 6.86 5.84 △13.40 12.19 △9.40 8.38 3 2 С 6.35 MAX 14.73 12.70 0,61 △0,33 1.78 1.14 (1.91) — ⊕ 0.36 M B AM 2.54 NOTES: UNLESS OTHERWISE SPECIFIED A) REFERENCE JEDEC, TO-220, ISSUE K, VARIATION AB, DATED APRIL, 2002. 5.08 B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSIONING AND TOLERANCING PER ANSI Y14.5 - 1973 D) LOCATION OF THE PIN HOLE MAY VARY (LOWER LEFT CORNER, LOWER CENTER) AND CENTER OF THE PACKAGE) LEDOES NOT COMPLY JEDEC STANDARD VALUE, SINGLE GAUGE = 0.51 - 0.61 DUAL GAUGE = 1.14 - 1.40 G) DRAWING FILE NAME: TO220B03REV6 ш **Dimensions in Millimeters**





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